Dual Boost Power Module

Product Preview

NXH40B120MNQ0SNG

Description

The NXH40B120MNQ0SNG is a power module containing a dual boost stage. The integrated SiC MOSFETs and SiC Diodes provide lower conduction losses and switching losses, enabling designers to achieve high efficiency and superior reliability.

Features

- 1200 V, $40 \text{ m}\Omega$ SiC MOSFETs
- Low Reverse Recovery and Fast Switching SiC Diodes
- 1200 V Bypass and Anti-parallel Diodes
- Low Inductive Layout
- Solder Pins
- Thermistor
- These Device is Pb-Free, Halogen Free and is RoHS Compliant

Typical Applications

- Solar Inverter
- Uninterruptible Power Supplies

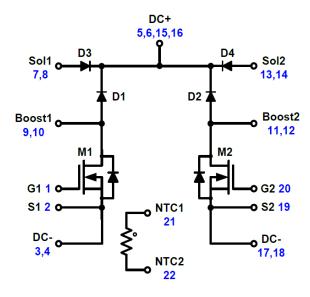
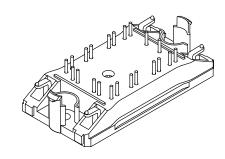


Figure 1. NXH40B120MNQ0SNG Schematic Diagram

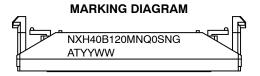


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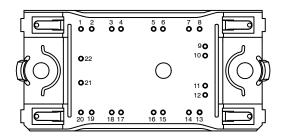


Q0BOOST CASE 180AJ **SOLDER PINS**



= Assembly Site Code Т = Test Site Code G = Pb- Free Package = Year and Work Week Code NXH40B120MNQ0SNG = Specific Device Code

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information on page 4 of this data sheet.

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.

ABSOLUTE MAXIMUM RATINGS (Note 1) (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
BOOST MOSFET			
Drain-Source Voltage	V _{DS}	1200	V
Gate-Source Voltage	V _{GS}	-15/+25	V
Continuous Drain Current (@ $V_{GS} = 20 \text{ V}$, $T_C = 80^{\circ}\text{C}$)	I _D	38	А
Pulsed Drain Current @ T _C = 80°C (T _J = 175°C)	I _{D(Pulse)}	114	А
Maximum Power Dissipation @ T _C = 80°C (T _J = 175°C)	P _{tot}	118	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	175	°C
BOOST DIODE			
Peak Repetitive Reverse Voltage	V _{RRM}	1200	V
Continuous Forward Current @ T _C = 80°C	I _F	45	А
Repetitive Peak Forward Current ($T_J = 175^{\circ}C$, tp limited by T_{Jmax})	I _{FRM}	135	А
Maximum Power Dissipation @ T _C = 80°C (T _J = 175°C)	P _{tot}	118	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	175	°C
BYPASS DIODE			
Peak Repetitive Reverse Voltage	V _{RRM}	1200	V
Continuous Forward Current @ T _C = 80°C (T _J = 150°C)	I _F	50	А
Repetitive Peak Forward Current (T _J = 150°C, t _p limited by T _{Jmax})	I _{FRM}	150	А
Power Dissipation Per Diode @ T _C = 80°C (T _J = 175 °C)	P _{tot}	61	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	150	°C
THERMAL PROPERTIES			_
Storage Temperature Range	T _{stg}	-40 to 125	°C
INSULATION PROPERTIES			
Isolation Test Voltage, t = 1 sec, 60 Hz	V _{is}	3000	V _{RMS}
Creepage Distance		12.7	mm

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

RECOMMENDED OPERATING RANGES

Rating	Symbol	Min	Max	Unit
Module Operating Junction Temperature	T_J	-40	(T _{Jmax} -25)	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

Refer to ELECTRICAL CHĂRACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

ELECTRICAL CHARACTERISTICS (T_{.I} = 25°C unless otherwise noted)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
BOOST MOSFET CHARACTERISTICS			•			•
Zero Gate Voltage Drain Current	$V_{GS} = 0 \text{ V, } V_{DS} = 1200 \text{ V,} $ $T_{J} = 25^{\circ}\text{C}$	I _{DSS}	-	=	200	μΑ
Static Drain-to-Source On Resistance	$V_{GS} = 20 \text{ V, } I_D = 40 \text{ A,}$ $T_J = 25^{\circ}\text{C}$	R _{DS(on)}	_	40	55	mΩ
	V _{GS} = 20 V, I _D = 40 A, T _J = 175°C		_	60	_	
Gate-Source Leakage Current	$V_{GS} = -15 \text{ V} / +25 \text{ V},$ $V_{DS} = 0 \text{ V}$	I _{GSS}	-	-	1	μΑ
Turn-on Delay Time	$T_J = 25^{\circ}C, V_{DS} = 700 V,$	t _{d(on)}	_	17	-	ns
Rise Time	$I_D = 40 \text{ A}, V_{GS} = -5 \text{ V} / 20 \text{ V},$ $R_G = 4.7 \Omega$	t _r	-	7.5	_	1
Turn-off Delay Time		t _{d(off)}	=	43.8	=	1
Fall Time		t _f	-	17	-	1
Turn-on Switching Loss per Pulse		E _{on}	-	255	-	μJ
Turn-off Switching Loss per Pulse		E _{off}	-	125.5	-	μJ
Turn-on Delay Time	$T_J = 125^{\circ}C, V_{DS} = 700 V,$	t _{d(on)}	-	15.8	-	ns
Rise Time	$I_D = 40 \text{ A}, V_{GS} = -5 \text{ V} / 20 \text{ V},$ $R_G = 4.7 \Omega$	t _r	_	7	-	1
Turn-off Delay Time		t _{d(off)}	-	46.5	_	1
Fall Time		t _f	-	13.5	_	1
Turn-on Switching Loss per Pulse		E _{on}	_	383	_	μJ
Turn-off Switching Loss per Pulse		E _{off}	-	108.5	-	μJ
Input Capacitance	V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz	C _{ies}	-	3227	-	pF
Output Capacitance	1 - 1 WII 12	C _{oes}	-	829	-	pF
Reverse Transfer Capacitance		C _{res}	-	19	-	pF
Total Gate Charge	V _{DS} = 600 V, I _D = 20 A, V _{GS} = 20 V, -15 V	Q_{g}	-	146.72	=	nC
Thermal Resistance - Chip-to-Case	Thermal grease, Thickness = 2.1 Mil ±2%	R _{thJC}	-	0.81	-	K/W
Thermal Resistance - Chip-to-Heatsink	$\lambda = 2.9 \text{ W/mK}$	R_{thJH}	-	1.26	-	K/W
BOOST DIODE CHARACTERISTICS						
Diode Reverse Leakage Current	V _R = 1200 V	I_{R}	_	-	400	μΑ
Diode Forward Voltage	I _F = 40 A, T _J = 25°C	V_{F}	_	1.50	1.75	V
	I _F = 40 A, T _J = 175°C		_	2.17	-	
Reverse Recovery Time	$T_J = 25^{\circ}C$ $V_{DS} = 700 \text{ V}, I_D = 40 \text{ A}$	t _{rr}	_	16.7	-	ns
Reverse Recovery Charge	$V_{GS} = -5 \text{ V} / 20 \text{ V},$ $R_G = 4.7 \Omega$	Q _{rr}	_	329.6	-	nC
Peak Reverse Recovery Current	~ _	I _{RRM}	-	34.3	-	Α
Peak Rate of Fall of Recovery Current	_	di/dt	_	6684	_	A/μs
Reverse Recovery Energy		E_{rr}	_	176.6	_	μJ

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
BOOST DIODE CHARACTERISTICS				•	•	
Reverse Recovery Time	T _J = 125°C	t _{rr}	-	16.9	_	ns
Reverse Recovery Charge	$V_{DS} = 700 \text{ V}, I_D = 40 \text{ A}$ $V_{GS} = -5 \text{ V} / 20 \text{ V},$	Q _{rr}	_	361	_	nC
Peak Reverse Recovery Current	$R_G = 4.7 \Omega$	I _{RRM}	_	37	_	Α
Peak Rate of Fall of Recovery Current		di/dt	_	8067	_	A/μs
Reverse Recovery Energy		E _{rr}	_	209.1	_	μJ
Thermal Resistance - Chip-to-Case	Thermal grease, Thickness = 2.1 Mil ±2%	R_{thJC}	_	0.70	_	K/W
Thermal Resistance - Chip-to-Heatsink	$\lambda = 2.9 \text{ W/mK}$	R _{thJH}	-	1.14	=	K/W
BYPASS DIODE CHARACTERISTICS				_		
Diode Reverse Leakage Current	V _R = 1200 V, T _J = 25°C	I _R	=	-	250	μΑ
Diode Forward Voltage	I _F = 50 A, T _J = 25°C	V _F	_	1.11	1.3	V
	I _F = 50 A, T _J = 150°C		-	1.00	_	
Thermal Resistance - Chip-to-Case	Thermal grease, Thickness = 2.1 Mil ±2%	R _{thJC}	=	1.15	=	K/W
Thermal Resistance - Chip-to-Heatsink	$\lambda = 2.9 \text{ W/mK}$	R _{thJC}	-	1.75	_	K/W
THERMISTOR CHARACTERISTICS	•					
Nominal Resistance		R ₂₅	-	22	-	kΩ
Nominal Resistance	T = 100°C	R ₁₀₀	-	1486	-	Ω
Deviation of R25		ΔR/R	-5	-	5	%
Power Dissipation		P_{D}	-	200	_	mW
Power Dissipation Constant			_	2	_	mW/K
B-value	B (25/50), tolerance ±3%		_	3950	_	К
B-value	B (25/100), tolerance ±3%		_	3998	_	K

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

PACKAGE MARKING AND ORDERING INFORMATION

Orderable Part Number	Marking	Package	Shipping
NXH40B120MNQ0SNG	NXH40B120MNQ0SNG	Q0PACK - Case 180AJ (Pb-Free and Halide-Free Solder Pins)	24 Units / Blister Tray

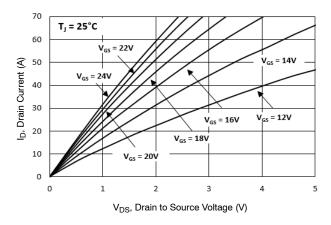


Figure 2. MOSFET on Region Characteristics

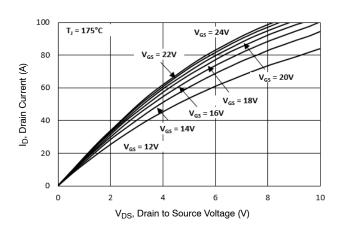


Figure 3. MOSFET on Region Characteristics

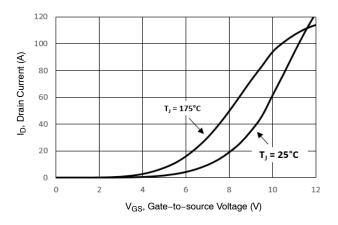


Figure 4. MOSFET Transfer Characteristics

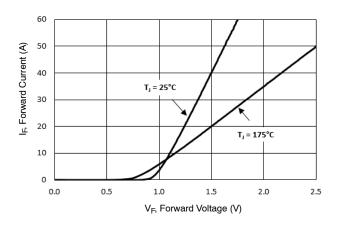


Figure 5. Boost Diode Forward Characteristics

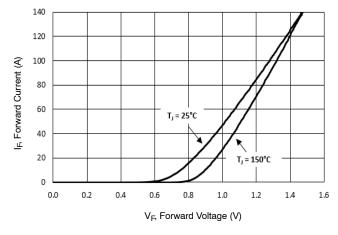


Figure 6. Bypass Diode Forward Characteristics

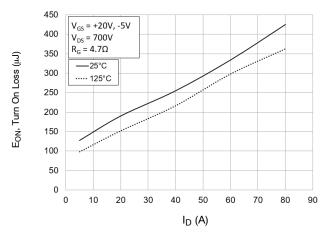


Figure 7. Typical Turn On Loss vs. ID

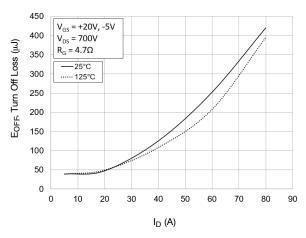


Figure 8. Typical Turn Off Loss vs. ID

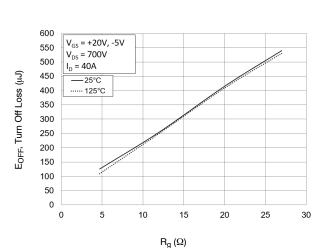


Figure 10. Typical Turn Off Loss vs. R_G

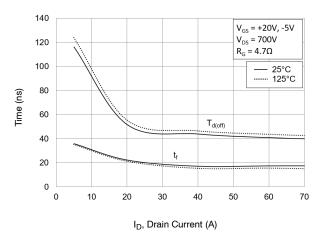


Figure 12. Typical Turn-Off Switching Time vs. I_D

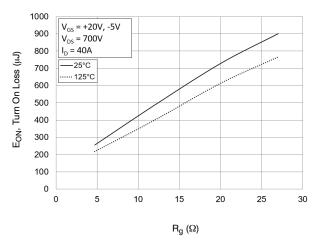


Figure 9. Typical Turn On Loss vs. R_G

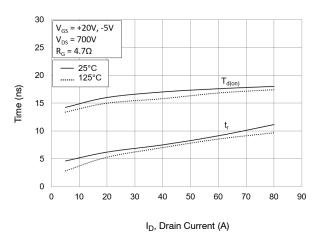


Figure 11. Typical Turn-On Switching Time vs. I_D

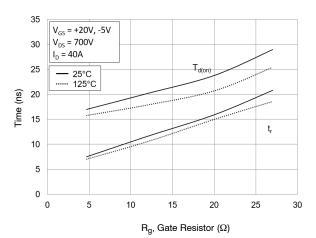


Figure 13. Typical Turn-On Switching Time vs. R_G

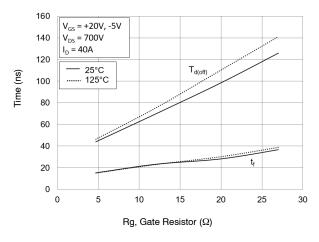


Figure 14. Typical Turn-Off Switching Time vs. R_G

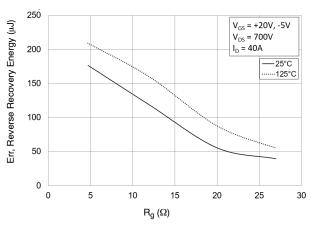


Figure 16. Typical Reverse Recovery Energy Loss vs. R_G

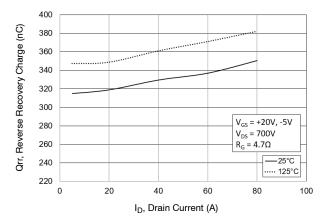


Figure 18. Typical Reverse Recovery Charge vs. I_D

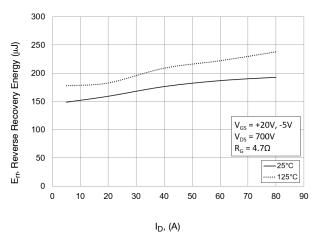


Figure 15. Typical Reverse Recovery Energy Loss vs. I_D

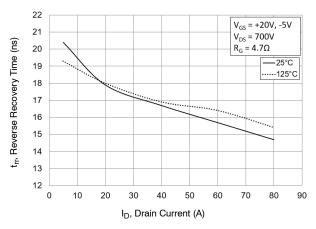


Figure 17. Typical Reverse Recovery Time vs. I_D

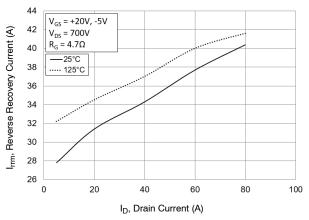


Figure 19. Typical Reverse Recovery Peak Current vs. I_D

TYPICAL CHARACTERISTICS - MOSFET, BOOST DIODE AND BYPASS DIODE (continued)

25

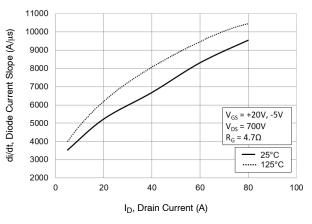
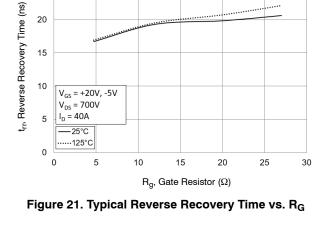


Figure 20. Typical di/dt Current Slope vs. I_D



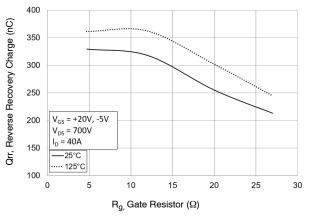


Figure 22. Typical Reverse Recovery Charge vs. R_G

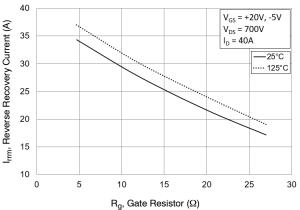


Figure 23. Typical Reverse Recovery Peak Current vs. R_G

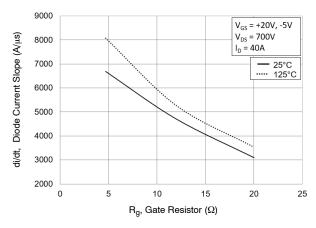


Figure 24. Typical di/dt vs. R_G

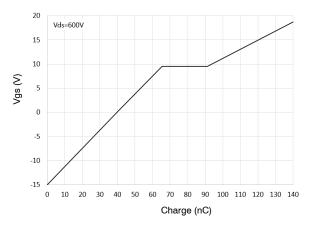


Figure 25. Gate Voltage vs. Gate Charge

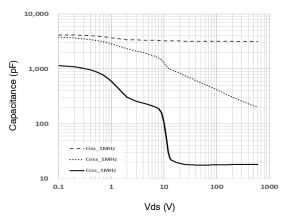


Figure 26. Capacitance Charge

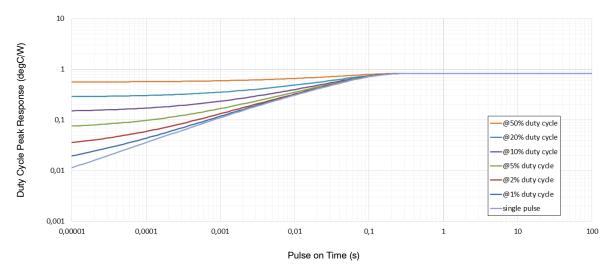


Figure 27. Mosfet Transient Thermal Impedance

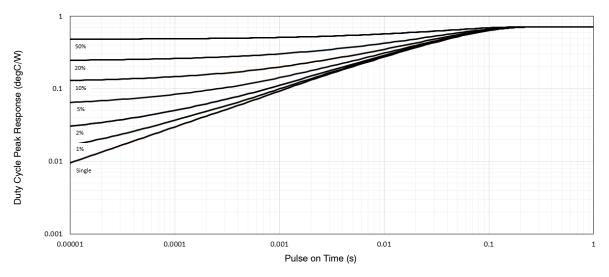


Figure 28. Boost Diode Transient Thermal Impedance

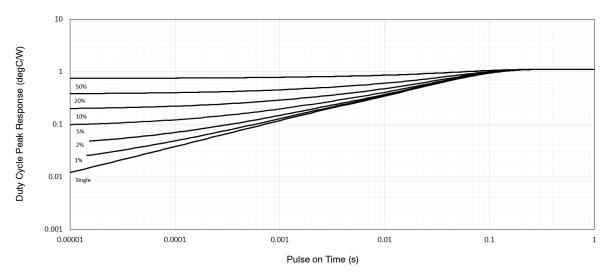


Figure 29. Bypass Diode Transient Thermal Impedance

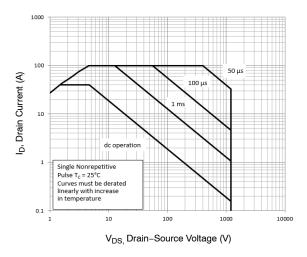


Figure 30. FBSOA for MOSFET

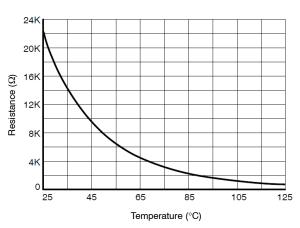


Figure 32. Thermistor Characteristics

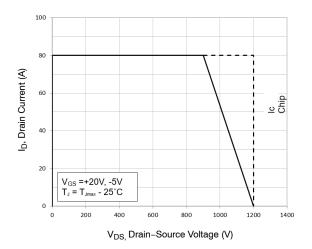
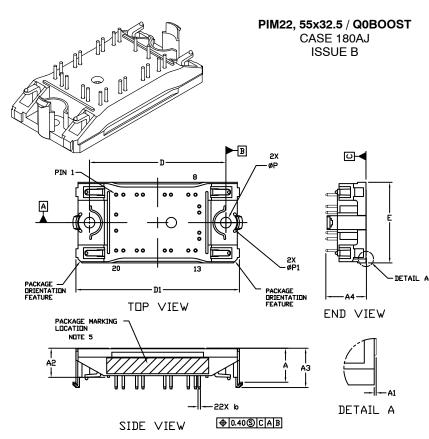


Figure 31. RBSOA for MOSFET



DATE 08 NOV 2017

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER. ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSION 6 APPLIES TO THE PLATED TERMINALS AND IS MEASURED BETWEEN 1.00 AND 3.00 FROM THE TERMINAL TIP.
- 4. POSITION OF THE CENTER OF THE TERMINALS
 IS DETERMINED FROM DATUM B THE CENTER OF
 DIMENSION D, X DIRECTION, AND FROM DATUM A,
 Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED
 IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH
 DIRECTIONS.
- PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.

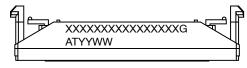
	MILLIMETERS				
DIM	MIN.	NDM.			
A	13.50	13.90			
A1	0.10	0.30			
A2	11.50	11.90			
A3	15.65	16.05			
A4	16.35 REF				
۵	0.95	1.05			
D	54.80	55.20			
D1	65.60	66.20			
E	32.20	32.80			
Ք	4.20	4.40			
P1	8.90	9.10			

MOUNTING HOLE POSITION

NOTE 4

	HOLE P	OSITION		PIN PE	NDITIZE	PIN POSITION			PIN PI	NDITIZE	
PIN	Х	Y	PIN	Х	Υ	PIN	Х	Y	PIN	Х	Υ
1	-16.75	-11.25	12	16.75	6.55	1	-16.75	11.25	12	16.75	-6.55
2	-13.85	-11.25	13	15.25	11.25	2	-13.85	11.25	13	15.25	-11.25
3	-8.45	-11.25	14	12.35	11.25	3	-8.45	11.25	14	12.35	-11.25
4	-5.95	-11.25	15	5.35	11.25	4	-5.95	11.25	15	5.35	-11.25
5	2.85	-11.25	16	2.85	11.25	5	2.85	11.25	16	2.85	-11.25
6	5.35	-11.25	17	-5.95	11.25	6	5.35	11.25	17	-5.95	-11.25
7	12.35	-11.25	18	-8.45	11.25	7	12.35	11.25	18	-8.45	-11.25
8	15.25	-11.25	19	-13.85	11.25	8	15.25	11.25	19	-13.85	-11.25
9	16.75	-6.55	20	-16.75	11.25	9	16.75	6.55	20	-16.75	-11.25
10	16.75	-4.05	21	-16.75	3.25	10	16.75	4.05	21	-16.75	-3.25
11	16.75	4.05	22	-16.75	-3.25	11	16.75	-4.05	22	-16.75	3.25

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code

a = Pb-Free Package

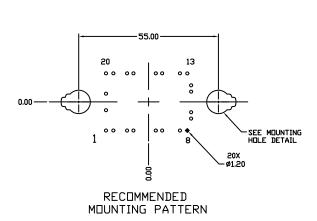
AT = Assembly & Test Site Code

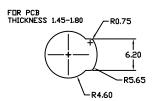
YYWW = Year and Work Week Code

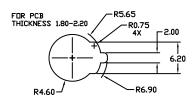
*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

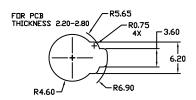
DOCUMENT NUMBER:	98AON63481G	Electronic versions are uncontrolled except when accessed directly from the Document Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.			
DESCRIPTION:	PIM22 55X32.5 / Q0BOOST	(SOLDER PIN)	PAGE 1 OF 2		

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MOUNTING HOLE DETAIL

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DESCRIPTION:	PIM22 55X32.5 / Q0BOOST	(SOLDER PIN)	PAGE 2 OF 2	

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